July 2001

# FAIRCHILD SEMICONDUCTOR®

# FDD6530A

# 20V N-Channel PowerTrench<sup>®</sup> MOSFET

### **General Description**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low RDS( ON) and fast switching speed.

# Applications

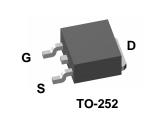
- DC/DC converter
- Motor drives

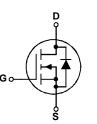
## Features

- 21 A, 20 V  $R_{DS(ON)} = 32 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$  $R_{DS(ON)} = 47 \text{ m}\Omega @ V_{GS} = 2.5 \text{ V}$
- Low gate charge (6.5 nC typical)
- Fast switching

.

+ High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$ 





## Absolute Maximum Ratings T<sub>A=25°C</sub> unless otherwise noted

Symbol	Parameter		Ratings	Units	
V <sub>DSS</sub>	Drain-Source Voltage		20	V	
V <sub>GSS</sub>	Gate-Source Voltage		±8	V	
I <sub>D</sub>	Drain Current – Continuous	(Note 3)	21	А	
	– Pulsed	(Note 1a)	100		
PD	Power Dissipation	(Note 1)	33	W	
		(Note 1a)	3.3		
		(Note 1b)	1.6		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Tem	perature Range	-55 to +175	°C	

# **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	4.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	45	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	96	°C/W

# Package Marking and Ordering Information

EDD6530A EDD6530A 13" 16mm 250	uantity	lth	Tape width	Reel Size	Device	Device Marking
	00 units		16mm	13"	FDD6530A	FDD6530A

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Drain-So	Parameter	Test Conditions	Min	Тур	Max	Units
	ource Avalanche Ratings (Note	e 2)	•			
W <sub>DSS</sub>	Drain-Source Avalanche Energy	Single Pulse, $V_{DD} = 10 V$			55	mJ
AR	Drain-Source Avalanche Current				8	А
Off Char	acteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V$ , $I_D = 250 \mu A$	20			V
<u>ΔBVdss</u> ΔTj	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , Referenced to $25^{\circ}\text{C}$		15		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 16 \text{ V}, \qquad V_{\text{GS}} = 0 \text{ V}$			1	μA
GSSF	Gate-Body Leakage, Forward	$V_{GS} = 8 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
GSSR	Gate-Body Leakage, Reverse	$V_{GS} = -8 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	0.4	0.9	1.2	V
$\Delta V_{GS(th)} \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = 250 µA, Referenced to 25°C		-3		mV/°C
RDS(on)	Static Drain–Source On–Resistance	$ \begin{array}{ll} V_{GS} = 4.5 \ V, & I_D = 8 \ A \\ V_{GS} = 2.5 \ V, & I_D = 6.6 \ A \\ V_{GS} = 4.5 \ V, & I_D = 8 \ A, \ T_J = 125^\circ C \end{array} $		26 36 36	32 47 48	mΩ
D(on)	On–State Drain Current	$V_{GS} = 4.5 \text{ V},  V_{DS} = 5 \text{ V}$	20			А
FS	Forward Transconductance	$V_{\text{DS}} = 5 \text{ V}, \qquad I_{\text{D}} = 8 \text{ A}$		21		S
Dvnamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 10 \text{ V},  V_{GS} = 0 \text{ V},$		710		pF
Coss	Output Capacitance	f = 1.0 MHz		173		pF
Crss	Reverse Transfer Capacitance	-		84		pF
Switchin	g Characteristics (Note 2)					
d(on)	Turn–On Delay Time	$V_{DD} = 10 V$ , $I_D = 1 A$ ,		8	16	ns
r	Turn–On Rise Time	$V_{GS} = 4.5 V, R_{GEN} = 6$		7	14	ns
d(off)	Turn-Off Delay Time	-		18	32	ns
f	Turn-Off Fall Time	-		4	8	ns
<u>'</u> ק	Total Gate Charge	$V_{DS} = 10 \text{ V}, \qquad I_D = 8 \text{ A},$		6.5	9	nC
∽g ⊋ <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 4.5 V		1.3	Ŭ	nC
 Ω <sub>qd</sub>	Gate–Drain Charge	-		1.9		nC
ů.	ource Diode Characteristics	and Maximum Ratings				
s	Maximum Continuous Drain–Source				2.7	А
0	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_S = 2.7 \text{ A}$ (Note 2)		0.8	1.2	V

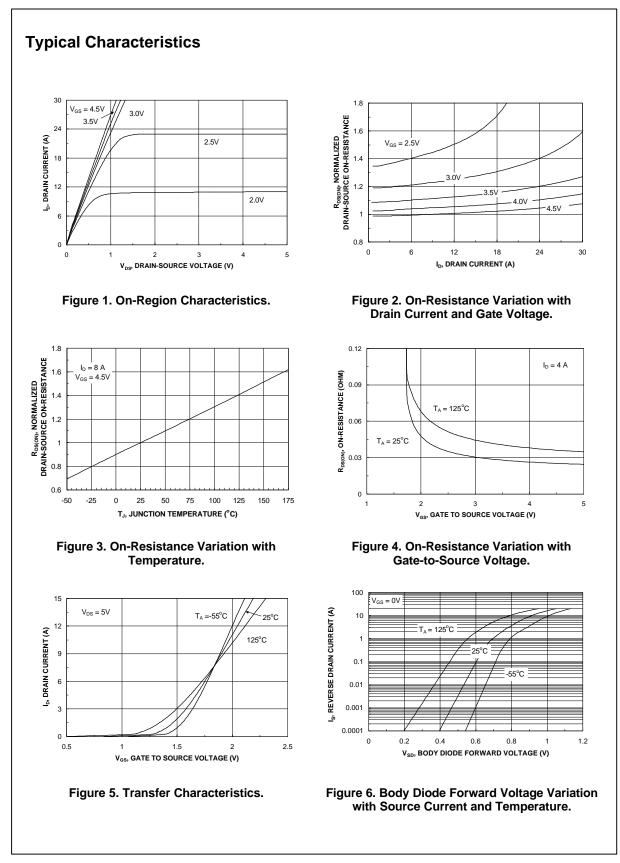
2. Pulse Test: Pulse Width < 300 $\mu$ s, Duty Cycle < 2.0%

3. Maximum current is calculated as:

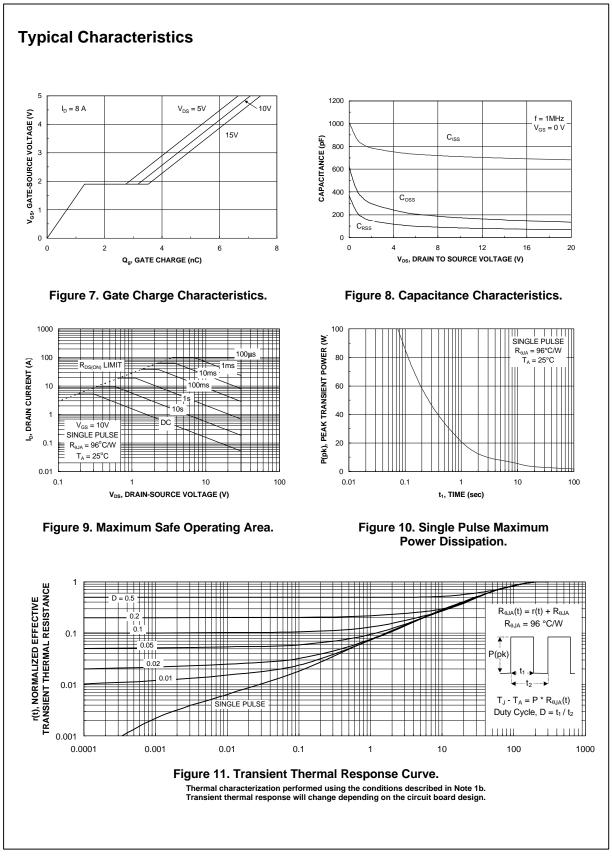
Maximum current is calculated as:  $\sqrt{\frac{P_D}{D_{PG(TMA)}}}$ where  $P_D$  is maximum power dissipation at  $T_C = 25^{\circ}C$  and  $R_{DS(on)}$  is at  $T_{J(max)}$  and  $V_{GS} = 10V$ . Package current limitation is 21A

FDD6530A Rev. C (W)

FDD6530A



# FDD6530A



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